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: May 31, 2019 : HYQ4AS

RADIO TEST REPORT

Test Report No.: 12747094H-A-R1

DENSO CORPORATION Applicant

Type of Equipment Electronic Key

Model No. 4AS

FCC ID **HYQ4AS**

FCC Part 15 Subpart C: 2018 **Test regulation**

Test Result Complied (Refer to SECTION 3.2)

- This test report shall not be reproduced in full or partial, without the written approval of UL Japan, Inc. 1.
- 2. The results in this report apply only to the sample tested.
- 3. This sample tested is in compliance with above regulation.
- 4. The test results in this report are traceable to the national or international standards.
- 5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
- The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab. 6.
- This test report must not be used by the customer to claim product certification, approval, or 7. endorsement by NVLAP, NIST, or any agency of the Federal Government.
- 8. The information provided from the customer for this report is identified in SECTION 1.
- 9. This report is a revised version of 12747094H-A. 12747094H-A is replaced with this report.

March 6 to April 16, 2019

Representative test engineer:

Date of test:

Takumi Shimada

Engineer Consumer Technology Division

Approved by:

Motoya Imura

Leader

Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation. *As for the range of Accreditation in NVLAP, you may refer to the WEB address,

http://japan.ul.com/resources/emc accredited/

The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.

There is no testing item of "Non-accreditation".

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REVISION HISTORY

Original Test Report No.: 12747094H-A

Revision	Test report No.	Date	Page revised	Contents
- (Original)	12747094H-A	April 24, 2019	-	-
1	12747094H-A-R1	May 31, 2019	P.14, 16	Correction of Sample calculation
1	12747094H-A-R1	May 31, 2019 May 31, 2019	P.18	Correction of Sample calculation Correction of the title of ASK data table (upper); From: 99% Occupied Bandwidth to: -20dB Bandwidth
	<u> </u>			

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SECTION 1: Customer information

Company Name : DENSO CORPORATION

Address : 1-1, Showa-cho, Kariya-shi, Aichi-ken, 448-8661, Japan

Telephone Number : +81-566-20-3955 Facsimile Number : +81-566-25-4837 Contact Person : TAKAYUKI HATTORI

The information provided from the customer is as follows;

- Applicant, Type of Equipment, Model No., FCC ID on the cover and other relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (E.U.T.)
- SECTION 4: Operation of E.U.T. during testing
- * The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Electronic Key

Model No. : 4AS

Serial No. : Refer to Section 4, Clause 4.2

Rating : DC 3.0 V

Receipt Date of Sample : February 27, 2019

(Information from test lab.)

Country of Mass-production : United States of America, China

Condition of EUT : Engineering prototype

(Not for Sale: This sample is equivalent to mass-produced items.)

Modification of EUT : No Modification by the test lab

2.2 Product Description

Model: 4AS (referred to as the EUT in this report) is a Electronic Key.

The EUT (4AS) transmits radio wave signals of ASK and FSK.

The radio wave signals of ASK and FSK are not transmitted simultaneously.

Either one of ASK and FSK is transmitted by operator's action. End users cannot control which of ASK and FSK to be transmitted.

EUT has variations of Type A and Type B.

The difference of these variations is only the outer case.

After test results of the two types were compared, the test was performed only with Type A as its result was the worst one.

Radio Specification

Radio Type : Transceiver Frequency of Operation : 314.9 MHz

Modulation : ASK (A1D) / FSK (F1D)

Type of Battery : One lithium battery

Antenna type : Built-in type (Fixed)

Clock frequency (Maximum) : 27.6 MHz Crystal

Radio Type : Receiver Frequency of Operation : 125 kHz *1)

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^{*1)} The test of receiver part was performed separately from this test report, and the conformability is confirmed.

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C

FCC Part 15 final revised on March 12, 2018 and effective April 11, 2018

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators

Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.10:2013 6 Standard test methods		-N/A	N/A	*1)
	IC: RSS-Gen 8.8	IC: RSS-Gen 8.8			
	FCC: ANSI C63.10:2013	FCC: Section			
Automatically Deactivate	6 Standard test methods	15.231(a)(1)	N/A	Complied	Radiated
	IC: -	IC: RSS-210 A1.1		a)	
	FCC: ANSI C63.10:2013	FCC: Section 15.231(b)	2.5 dB		
Electric Field Strength of Fundamental Emission	6 Standard test methods		314.900 MHz Horizontal	Complied#	Radiated
of Fundamental Emission	IC: RSS-Gen 6.12	IC: RSS-210 A1.2	PK with Duty Factor < FSK >	0)	
	FCC: ANSI C63.10:2013	FCC: Section 15.205	3.4 dB		
Electric Field Strength	6 Standard test methods	Section 15.209	2204.300 MHz	Complied#	Radiated
of Spurious Emission	l	Section 15.231(b)	Vertical	b)	
or Spurious Limission	IC: RSS-Gen 6.13	IC: RSS-210 A1.2, 4.4	PK with Duty Factor	0)	
		RSS-Gen 8.9	< ASK >		
· · · · · · · · · · · · · · · · · · ·	FCC: ANSI C63.10:2013	FCC: Section 15.231(c)			
-20dB Bandwidth	6 Standard test methods		N/A	Complied	Radiated
	IC: -	IC: Reference data		c)	

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

- a) Refer to APPENDIX 1 (data of Automatically deactivate)
- b) Refer to APPENDIX 1 (data of Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission))
- c) Refer to APPENDIX 1 (data of -20dB and 99% Occupied Bandwidth)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC Part 15.31 (e)

This test was performed with the New Battery (DC 3.0 V) and the constant voltage was supplied to the EUT during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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^{*1)} The test is not applicable since the EUT does not have AC Mains.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks	
99 % Occupied Bandwidth	IC: RSS-Gen 6.7	IC: RSS-210 A1.3	N/A	-	Radiated	
Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.						

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor k = 2.

Test distance	Radiated emission (+/-)
	9 kHz to 30 MHz
3 m	3.3 dB
10 m	3.2 dB

^{*}Measurement distance

	Radiated emission (Below 1 GHz)					
Polarity	(3 m	*)(+/-)	(10 m*)(+/-)			
	30 MHz to 200 MHz	200 MHz to 1000 MHz	30 MHz to 200 MHz	200 MHz to 1000 MHz		
Horizontal	4.8 dB	5.2 dB	4.8 dB	5.0 dB		
Vertical	5.0 dB	6.3 dB	4.9 dB	5.0 dB		

Radiated emission (Above 1 GHz)							
(3 m*)(+/-)		(1 m*)(+/-)		(10 m*)(+/-)			
1 GHz to 6 GHz	6 GHz to 18 GHz	10 GHz to 26.5 GHz	26.5 GHz to 40 GHz	1 GHz to 18 GHz			
5.0 dB	5.3 dB	5.8 dB	5.8 dB	5.2 dB			

^{*} Measurement distance

Automati	ally Deactivate	
0.10 %		

Bandwidth
0.96 %

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3.5 Test Location

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NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measuremen t distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

^{*} Size of vertical conducting plane (for Conducted Emission test): $2.0 \text{ m} \times 2.0 \text{ m}$ for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

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SECTION 4: Operation of E.U.T. during testing

4.1 **Operating Mode(s)**

Test Item*	Mode
Automatically Deactivate	Normal use mode ASK/FSK (314.9 MHz)
Electric Field Strength of Fundamental Emission	Transmitting mode ASK/FSK (314.9 MHz) *1)
Electric Field Strength of Spurious Emission	
-20 dB & 99 % Occupied Bandwidth	
Duty Cycle	

^{*} The system was configured in typical fashion (as a user would normally use it) for testing.

End users cannot change the settings of the output power of the product.

4.2 Configuration and peripherals



Description of EUT

٦	No.	Item	Model number	Serial number	Manufacturer	Remarks
	A	Electronic Key	4AS	No.2 *1)	DENSO CORPORATION	EUT
		-		No.1 *2)		

^{*1)} Used for Normal use mode

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^{*1)} The software of this mode is the same as one of normal product, except that EUT continues to transmit when transmitter button is being pressed (For Normal use mode, EUT stops to transmit in a given time, even if transceiver button is being pressed.)

^{*} Setup was taken into consideration and test data was taken under worse case conditions.

^{*2)} Used for Transmitting mode

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 30 MHz]

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

[For 30 MHz to 1 GHz]

EUT was placed on a urethane platform of nominal size, 1.0 m by 1.5 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

Test antenna was aimed at the EUT for receiving the maximum signal and always kept within the illumination area of the 3 dB beamwidth of the antenna.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

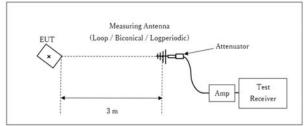
	From 9 kHz	From	From	From	From	Above 1 GHz
	to 90 kHz and	90 kHz	150 kHz	490 kHz	30 MHz	
	From 110 kHz	to 110 kHz	to 490 kHz	to 30 MHz	to 1 GHz	
	to 150 kHz					
Detector	Peak	Peak	Peak	Peak	Peak and	Peak and
Type					Peak with	Peak with Duty factor
					Duty factor	·
IF Bandwidth	200 Hz	200 Hz	9.0 kHz	9.0 kHz	120 kHz	PK: S/A: RBW 1 MHz,
						VBW: 3 MHz

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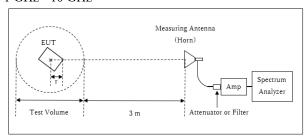
[Test Setup]

Below 1 GHz



× : Center of turn table

1 GHz - 10 GHz



- r : Radius of an outer periphery of EUT
- ×: Center of turn table

Test Distance: 3 m

Distance Factor: $20 \times \log (4.0 \text{ m} / 3.0 \text{ m}) = 2.50 \text{ dB}$ * Test Distance: (3 + Test Volume /2) - r = 4.0 m

Test Volume: 2.0 m

(Test Volume has been calibrated based on CISPR 16-1-4.)

r = 0.0 m

* The test was performed with r = 0.0 m since EUT is small and it was the rather conservative condition.

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test with mechanical key was the worst case. Therefore the test with mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9 kHz - 3.2 GHz Test data : APPENDIX

Test result : Pass

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX

Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used		
20 dB Bandwidth	300 kHz	3 kHz	9.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer		
99 % Occupied Bandwidth	Between 1.5 times and 5.0 times of the OBW	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold	Spectrum Analyzer		
Peak hold was appli	Peak hold was applied as Worst-case measurement.								

Test data : APPENDIX

Test result : Pass

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APPENDIX 1: Test data

Automatically deactivate

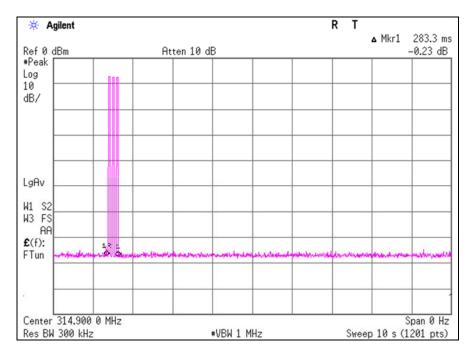
Report No. 12747094H

Test place Ise EMC Lab. No.6 Measurement Room

Date March 6, 2019
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Akihiko Maeda

Mode Normal Use Mode ASK (314.9 MHz)

Time of	Limit	Result
Transmitting		
[sec]	[sec]	
0.2833	5.00	Pass



^{*} The EUT transmits UHF when LF signal is received from a car or a button on the EUT is pressed. In both cases, the UHF transmission is stopped within 5 seconds. So the test was performed by a button-pressed operation as the worst case. Please refer to the "Theory of Operation" for details.

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Automatically deactivate

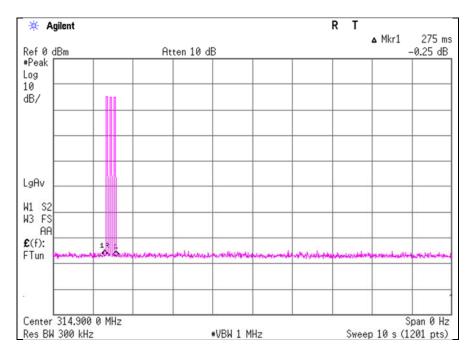
Report No. 12747094H

Test place Ise EMC Lab. No.6 Measurement Room

Date March 6, 2019
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Akihiko Maeda

Mode Normal Use Mode FSK (314.9 MHz)

Time of	Limit	Result
Transmitting		
[sec]	[sec]	
0.275	5.00	Pass



^{*} The EUT transmits UHF when LF signal is received from a car or a button on the EUT is pressed. In both cases, the UHF transmission is stopped within 5 seconds. So the test was performed by a button-pressed operation as the worst case. Please refer to the "Theory of Operation" for details.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

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Semi Anechoic Chamber No.4 No.4

Mode Transmitting Mode ASK (314.9 MHz)

QP or PK

A 10 19													
Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Res	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	Inside or Outside
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	of Restricted Bands
314.900	PK	93.4	89.4	14.0	10.1	31.9	-	85.6	81.6	95.6	10.0	14.0	Carrier
629.800	PK	52.2	51.5	19.4	11.9	32.1	-	51.4	50.7	75.6	24.2	24.9	Outside
944.700	PK	39.2	34.1	22.0	13.5	30.9	-	43.8	38.7	75.6	31.8	36.9	Outside
1259.600	PK	46.5	45.1	24.7	4.4	33.4	-	42.1	40.8	75.6	33.5	34.8	Outside
1574.500	PK	50.3	45.4	25.0	4.6	32.6	-	47.3	42.4	73.9	26.7	31.5	Inside
1889.400	PK	50.1	44.8	26.0	4.8	31.8	-	49.1	43.8	75.6	26.6	31.8	Outside
2204.300	PK	59.2	63.6	27.4	5.0	31.4	-	60.2	64.6	73.9	13.7	9.3	Inside
2519.200	PK	55.7	55.5	27.7	5.2	31.3	-	57.3	57.2	75.6	18.3	18.4	Outside
2834.100	PK	42.2	35.8	28.8	5.4	31.2	-	45.2	38.8	73.9	28.7	35.2	Inside
3149.000	PK	45.7	43.9	28.8	5.5	31.0	-	49.0	47.2	75.6	26.6	28.4	Outside

PK with Duty factor

Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Res	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	
314.900	PK	93.4	89.4	14.0	10.1	31.9	-14.1	71.5	67.5	75.6	4.1	8.1	Carrier
629.800	PK	52.2	51.5	19.4	11.9	32.1	-14.1	37.3	36.6	55.6	18.3	19.0	Outside
944.700	PK	39.2	34.1	22.0	13.5	30.9	-14.1	29.7	24.6	55.6	25.9	31.0	Outside
1259.600	PK	46.5	45.1	24.7	4.4	33.4	-14.1	28.0	26.7	55.6	27.6	28.9	Outside
1574.500	PK	50.3	45.4	25.0	4.6	32.6	-14.1	33.2	28.3	53.9	20.7	25.6	Inside
1889.400	PK	50.1	44.8	26.0	4.8	31.8	-14.1	35.0	29.7	55.6	20.6	25.9	Outside
2204.300	PK	59.2	63.6	27.4	5.0	31.4	-14.1	46.1	50.5	53.9	7.8	3.4	Inside
2519.200	PK	55.7	55.5	27.7	5.2	31.3	-14.1	43.2	43.1	55.6	12.4	12.5	Outside
2834.100	PK	42.2	35.8	28.8	5.4	31.2	-14.1	31.1	24.7	53.9	22.8	29.2	Inside
3149.000	PK	45.7	43.9	28.8	5.5	31.0	-14.1	34.9	33.1	55.6	20.7	22.5	Outside

^{*}Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator +Distance factor (above 1 GHz)} - Gain (Amplifier)
Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator +Distance factor (above 1 GHz)} - Gain (Amplifier)
+ Duty factor

For above 1GHz: Distance Factor: $20 \times \log (4.0 \text{ m/}3.0 \text{ m}) = 2.50 \text{ dB}$

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

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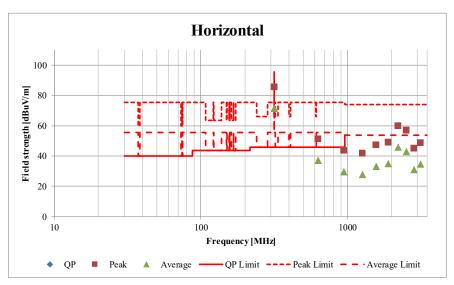
Radiated Spurious Emission (Plot data, Worst case)

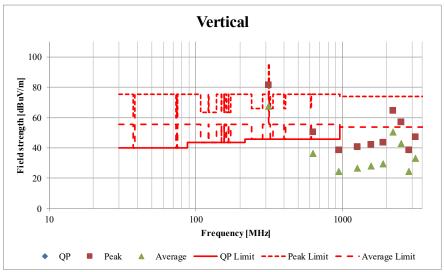
Report No. 12747094H Test place Ise EMC Lab.

Semi Anechoic Chamber No.4 No.4

Date April 15, 2019 April 16, 2019
Temperature / Humidity 22 deg. C / 30 % RH
Engineer Takumi Shimada (Below 1 GHz) April 16, 2019
21 deg. C / 27 % RH
Takumi Shimada (Above 1 GHz)

Mode Transmitting Mode ASK (314.9 MHz)





^{*}These plots data contains sufficient number to show the trend of characteristic features for EUT.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No. 12747094H Test place Ise EMC Lab.

Semi Anechoic Chamber No.4 No.4

Mode Transmitting Mode FSK (314.9 MHz)

QP or PK

QF 0F FK													
Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Re	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	Inside or Outside
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	of Restricted Bands
314.900	PK	90.1	86.8	14.0	10.1	31.9	-	82.3	79.0	95.6	13.3	16.6	Carrier
629.800	PK	48.8	48.3	19.4	11.9	32.1	-	48.0	47.5	75.6	27.6	28.1	Outside
944.700	PK	35.9	30.2	22.0	13.5	30.9	-	40.5	34.8	75.6	35.1	40.8	Outside
1259.600	PK	44.1	44.3	24.7	4.4	33.4	-	39.8	39.9	75.6	35.8	35.7	Outside
1574.500	PK	45.2	42.1	25.0	4.6	32.6	-	42.2	39.1	73.9	31.7	34.8	Inside
1889.400	PK	48.4	44.2	26.0	4.8	31.8	-	47.4	43.2	75.6	28.2	32.4	Outside
2204.300	PK	52.5	56.8	27.4	5.0	31.4	-	53.5	57.8	73.9	20.4	16.1	Inside
2519.200	PK	52.5	51.1	27.7	5.2	31.3	-	54.1	52.8	75.6	21.5	22.8	Outside
2834.100	PK	44.4	42.3	28.8	5.4	31.2	-	47.4	45.3	73.9	26.5	28.6	Inside
3149.000	PK	44.9	41.5	28.8	5.5	31.0	-	48.3	44.9	75.6	27.3	30.7	Outside

PK with Duty factor

rk with Duty	iactor												
Frequency	Detector	Rea	ding	Ant	Loss	Gain	Duty	Res	sult	Limit	Ma	rgin	Remark
		[dB	uV]	Factor			Factor	[dBu	V/m]		[d	B]	
[MHz]		Hor	Ver	[dB/m]	[dB]	[dB]	[dB]	Hor	Ver	[dBuV/m]	Hor	Ver	
314.900	PK	90.1	86.8	14.0	10.1	31.9	-9.2	73.1	69.8	75.6	2.5	5.8	Carrier
629.800	PK	48.8	48.3	19.4	11.9	32.1	-9.2	38.9	38.4	55.6	16.7	17.2	Outside
944.700	PK	35.9	30.2	22.0	13.5	30.9	-9.2	31.3	25.6	55.6	24.3	30.0	Outside
1259.600	PK	44.1	44.3	24.7	4.4	33.4	-9.2	30.7	30.8	55.6	25.0	24.8	Outside
1574.500	PK	45.2	42.1	25.0	4.6	32.6	-9.2	33.0	30.0	53.9	20.9	23.9	Inside
1889.400	PK	48.4	44.2	26.0	4.8	31.8	-9.2	38.3	34.0	55.6	17.4	21.6	Outside
2204.300	PK	52.5	56.8	27.4	5.0	31.4	-9.2	44.4	48.6	53.9	9.5	5.3	Inside
2519.200	PK	52.5	51.1	27.7	5.2	31.3	-9.2	45.0	43.6	55.6	10.6	12.0	Outside
2834.100	PK	44.4	42.3	28.8	5.4	31.2	-9.2	38.2	36.2	53.9	15.7	17.8	Inside
3149.000	PK	44.9	41.5	28.8	5.5	31.0	-9.2	39.1	35.7	55.6	16.5	19.9	Outside

^{*}Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Sample calculation:

Result of PK = Reading + Ant Factor + Loss {Cable + Attenuator + Distance factor (above 1 GHz)} - Gain (Amplifier)
Result of PK with Duty factor = Reading + Ant Factor + Loss {Cable + Attenuator + Distance factor (above 1 GHz)} - Gain (Amplifier)
+ Duty factor

For above 1GHz : Distance Factor: 20 x log (4.0 m/3.0 m) = 2.50 dB

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

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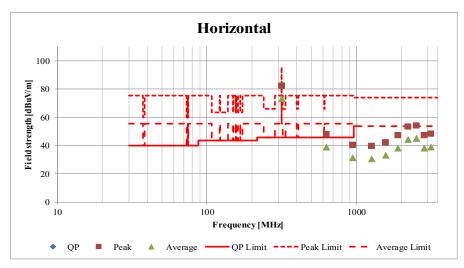
Radiated Spurious Emission (Plot data, Worst case)

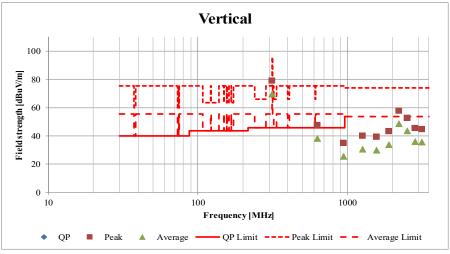
Report No. 12747094H Test place Ise EMC Lab.

Semi Anechoic Chamber No.4 No.4

Date April 15, 2019 April 16, 2019
Temperature / Humidity 22 deg. C / 30 % RH 21 deg. C / 27 % RH
Engineer Takumi Shimada (Below 1 GHz) (Above 1 GHz)

Mode Transmitting Mode FSK (314.9 MHz)





^{*}These plots data contains sufficient number to show the trend of characteristic features for EUT.

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-20dB and 99% Occupied Bandwidth

Report No. 12747094H

Test place Ise EMC Lab. No.6 Measurement Room

Date March 6, 2019
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Akihiko Maeda

Mode Transmitting Mode ASK/FSK (314.9 MHz)

ASK

Bandwidth Limit: Fundamental Frequency 314.90 MHz x 0.25% = 787.25 kHz

-20dB Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
28.430	787.25	Pass

99% Occupied Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
79.1536	787.25	Pass

FSK

Bandwidth Limit: Fundamental Frequency 314.90 MHz x 0.25% = 787.25 kHz

-20dB Bandwidth	Bandwidth Limit	Result
[kHz]	[kHz]	
86.912	787.25	Pass

Ī	99% Occupied Bandwidth	Bandwidth Limit	Result
L	[kHz]	[kHz]	
Ī	88.0167	787.25	Pass

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-20dB and 99% Occupied Bandwidth

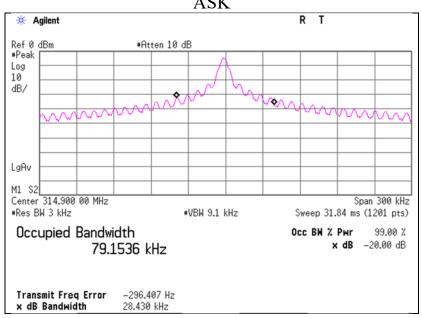
Report No. 12747094H

Test place Ise EMC Lab. No.6 Measurement Room

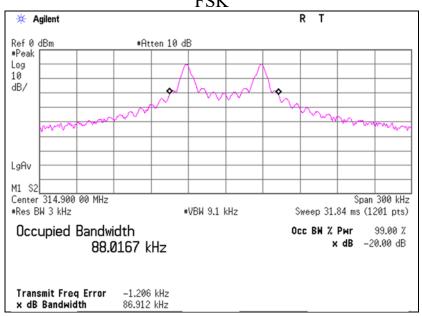
Date March 6, 2019 Temperature / Humidity 22 deg. C / 40 % RH Akihiko Maeda Engineer

Transmitting Mode ASK/FSK (314.9 MHz) Mode





FSK



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Duty Cycle

Report No. 12747094H

Test place Ise EMC Lab. No.6 Measurement Room

Date March 6, 2019
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Akihiko Maeda

Mode Transmitting Mode ASK (314.9 MHz)

		ON time(One pulse)	ON time(in 100ms)	
Type	Times	[ms]	[ms]	
A	70	0.139	9.702	
В	38	0.265	10.055	

^{*1)}ON time(in 100ms) = Times (in 50ms) * ON time(One pulse) *2

(Total)

ON time	Cycle	Duty	Duty	
[ms]	[ms]	(On time/Cycle)	[dB]	
19.757	100.00	0.1976	-14.09	

^{*3)}ON time = Type A's ON time (in 100ms) + Type B's ON time (in 100ms)

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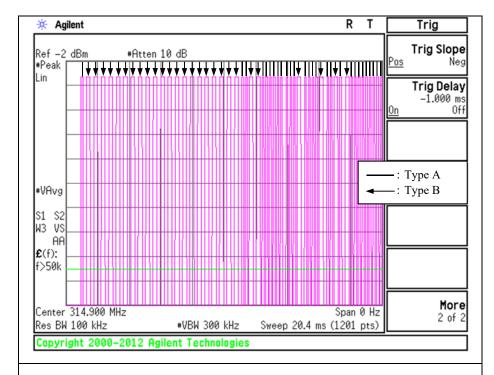
^{*2)}The train of pulses was exceeding 100msec, and that sampled 100msec was the worst case against the pulse train.

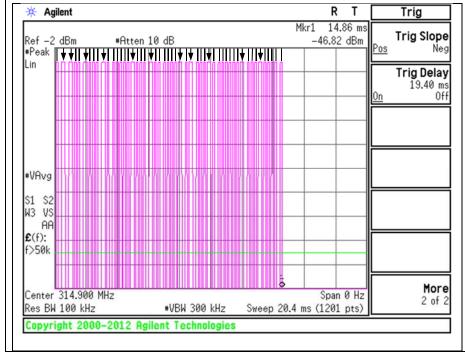
^{*4)}Duty = 20log10(ON time/Cycle)

^{*}The test was performed by a button-pressed operation as the worst case. Please refer to the "Theory of Operation" for details.

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Duty Cycle

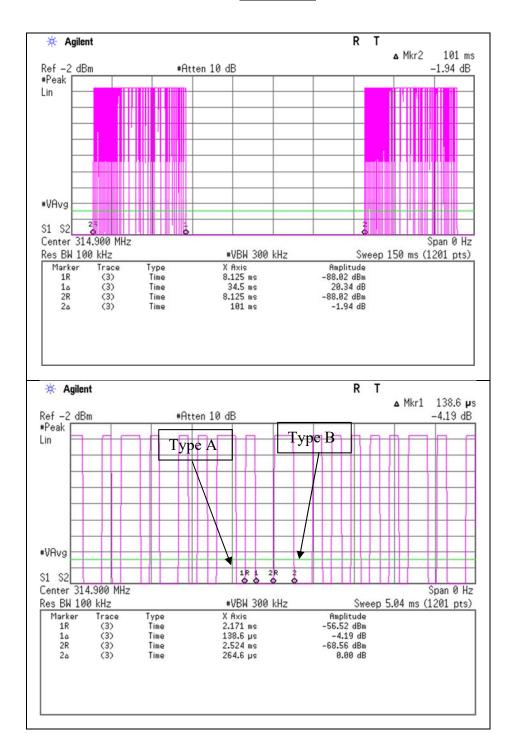




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Report No. 12747094H

Test place Ise EMC Lab. No.6 Measurement Room

Date March 6, 2019
Temperature / Humidity 22 deg. C / 40 % RH
Engineer Akihiko Maeda

Mode Transmitting Mode FSK(314.9MHz)

(Total)

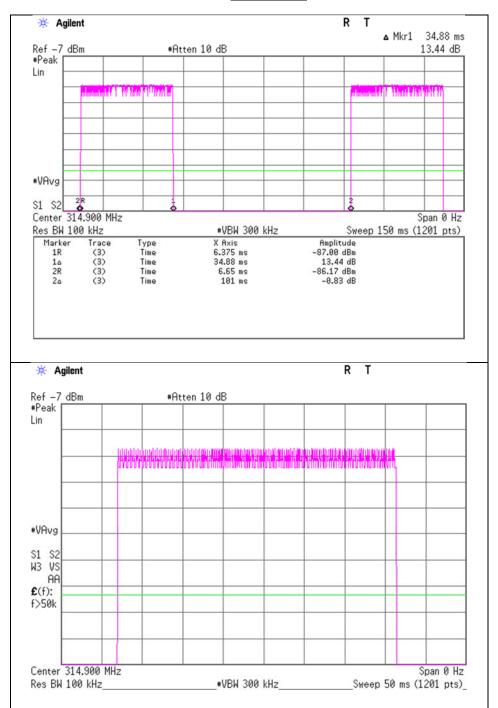
ON time	Cycle	Duty	Duty	
[ms]	[ms]	(On time/Cycle)	[dB]	
34.880	100.00	0.3488	-9.15	

^{*1)}Duty = 20log10(ON time/Cycle)

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APPENDIX 2: Test instruments

Test Instruments

Test item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	141899	Spectrum Analyzer	AGILENT	E4448A	MY46180655	8/10/2018	8/31/2019	12
RE	141561	Thermo-Hygrometer	CUSTOM	CTH-201	1401	1/11/2019	1/31/2020	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	148898	Attenuator	KEYSIGHT	8491A	MY52462282	10/3/2018	10/31/2019	12
RE	141267	Logperiodic Antenna(200- 1000MHz)	Schwarzbeck	VUSLP9111B	911B-192	3/21/2019	3/31/2020	12
RE	141583	Pre Amplifier	SONOMA INSTRUMENT	310	260833	2/8/2019	2/29/2020	12
RE	141562	Thermo-Hygrometer	CUSTOM	CTH-201	0010	1/11/2019	1/31/2020	12
RE	142227	Measure	KOMELON	KMC-36	-	-	-	-
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	6/28/2018	6/30/2020	24
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	8/6/2018	8/31/2019	12
RE	141545	DIGITAL HITESTER	HIOKI	3805	51201148	1/29/2019	1/31/2020	12
RE	141425	Biconical Antenna	Schwarzbeck	BBA9106	1302	6/1/2018	6/30/2019	12
RE	141397	Coaxial Cable	UL Japan	-	-	6/13/2018	6/30/2019	12
RE	141508	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	9120D-557	6/8/2018	6/30/2019	12
RE	141506	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170307	6/8/2018	6/30/2019	12
RE	141581	MicroWave System Amplifier	AGILENT	83017A	650	10/4/2018	10/31/2019	12
RE	141412	Microwave Cable	Junkosha	MWX221	1305S002R(1m) / 1405S146(5m)	6/14/2018	6/30/2019	12
RE	142017	AC4_Semi Anechoic Chamber(SVSWR)	TDK	Semi Anechoic Chamber 3m	DA-10005	4/7/2018	4/30/2019	12
RE	142645	Loop Antenna	UL Japan	-	-	-	-	-

^{*}Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:

RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth, Automatically deactivate and Duty cycle tests

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